## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination JOHNSON ET AL. Examiner Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,616,684	11-1971		73/635
*	В	US-2005/0124889 A1	06-2005	Flesch, Aime	600/445
*	С	US-3,938,372	02-1976	Sproule, Donald Orr	73/633
*	D	US-5,460,179	10-1995	Okunuki et al.	600/444
*	Ε	US-6,120,452	09-2000	Barthe et al.	600/459
*	F	US-4,368,644	01-1983	Wentzell et al.	73/634
*	G	US-4,641,532	02-1987	Rohrer, Edwin H.	73/637
*	Н	US-5,228,343	07-1993	Schoenen et al.	73/644
*	1	US-4,455,872	06-1984	Kossoff et al.	73/618
*	J	US-6,886,407	05-2005	Fredenberg, Richard Wayne	73/622
*	К	US-2005/0288587 A1	12-2005	Roh et al.	600/445
*	L	US-2005/0124889 A1	06-2005	Flesch, Aime	600/445
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s				<u> </u>	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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